## Application/Control No. 09/727,050 Applicant(s)/Patent Under R examination DEBONNETT, ALLISON P. Examiner Mark Fadok Applicant(s)/Patent Under R examination DEBONNETT, ALLISON P. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2001/0011250	08-2001	PALTENGHE et al.	705/41
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